Power MOSFET

-30 V, -5.9 A, μCool™ Single P-Channel, 2x2 mm, WDFN Package

Features

- WDFN Package with Exposed Drain Pad for Excellent Thermal Conduction
- 2x2 mm Footprint Same as SC-88 Package
- Low Profile (< 0.8 mm) for Easy Fit in Thin Environments
- This is a Pb-Free Device

Applications

- Li Ion Battery Linear Mode Charging for Portable Power Management in Noisy Environment
- DC-DC Conversion Buck/Boost Circuits
- High Side Switching

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	-30	V
Gate-to-Source Voltage	Gate-to-Source Voltage			±12	V
Continuous Drain	Steady T _A = 25°C			-4.5	Α
Current (Note 1)	State	T _A = 85°C	I_{D}	-3.3	
	t ≤ 5 s	T _A = 25°C		-5.9	
Power Dissipation (Note 1)	Steady State	T _A = 25°C	P _D	1.9	W
	t ≤ 5 s]		3.2	
Continuous Drain	$ \begin{array}{c} T_A = 25^{\circ}C \\ \text{Steady} \\ \text{State} \end{array} $ $ \begin{array}{c} T_A = 85^{\circ}C \\ T_A = 25^{\circ}C \end{array} $			-2.7	Α
Current (Note 2)			I _D	-2.0	
Power Dissipation (Note 2)			P _D	0.7	W
Pulsed Drain Current	t _p = 10 μs		I _{DM}	-18	Α
Operating Junction and Storage Temperature			T _J , T _{STG}	-55 to 150	°C
Source Current (Body Diode) (Note 2)			I _S	-1.5	Α
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

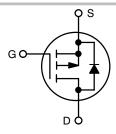
- Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
- 2. Surface Mounted on FR4 Board using the minimum recommended pad size.



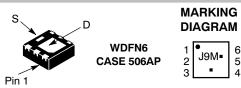
ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(on)} MAX	
-30 V	62 mΩ @ -4.5 V	
00 1	75 mΩ @ -2.5 V	



P-CHANNEL MOSFET



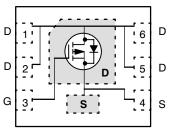
J9 = Specific Device Code

M = Date Code

= Pb-Free Package

(Note: Microdot may be in either location)

PIN CONNECTIONS



(Top View)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTLJS4149PTAG	WDFN6 (Pb-Free)	3000/Tape & Reel
NTLJS4149PTBG	WDFN6 (Pb-Free)	3000/Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 3)	$R_{ heta JA}$	65	°C/W
Junction-to-Ambient $-t \le 5$ s (Note 3)	$R_{ heta JA}$	38	
Junction-to-Ambient - Steady State Min Pad (Note 4)	R_{\thetaJA}	180	

- Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
 Surface Mounted on FR4 Board using the minimum recommended pad size.

$\textbf{MOSFET ELECTRICAL CHARACTERISTICS} \ (T_J = 25^{\circ}\text{C unless otherwise noted})$

Parameter	Symbol	Test Condition	ıs	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•						•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V, } I_{D} = -250 \mu\text{A}$		-30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	$I_D = -250 \mu\text{A}$, Ref to 25°C			-1.8		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = -24 V, V _{GS} = 0 V	$T_J = 25^{\circ}C$		-0.1	-1.0	μΑ
		v _{DS} = -24 v, v _{GS} = 0 v	T _J = 85°C		-1.0	-10	1
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm$	12 V			±0.1	μΑ
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D} = -250 \mu A$		-0.4		-1.0	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				3.1		mV/°C
Drain-to-Source On-Resistance	R _{DS(on)}	$V_{GS} = -4.5 \text{ V}, I_D = -4.5 \text{ V}$	2.0 A		43	62	mΩ
		$V_{GS} = -2.5 \text{ V}, I_D = -$	·2.0 A		56	75	1
		$V_{GS} = -4.5 \text{ V}, I_D = -4.5 \text{ V}$	4.5 A		43	62	1
Forward Transconductance	9 _{FS}	$V_{DS} = -6.0 \text{ V}, I_D = -3.0 \text{ A}$			10		S
CHARGES, CAPACITANCES AND GA	TE RESISTANO	CE					
Input Capacitance	C _{ISS}	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = -15 \text{ V}$			960		pF
Output Capacitance	Coss				130		
Reverse Transfer Capacitance	C _{RSS}				80		1
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = -4.5 \text{ V}, V_{DS} = -15 \text{ V},$ $I_{D} = -2.0 \text{ A}$			9.9	15	nC
Threshold Gate Charge	Q _{G(TH)}				0.8		1
Gate-to-Source Charge	Q_{GS}				1.45		1
Gate-to-Drain Charge	Q_{GD}				2.75		
SWITCHING CHARACTERISTICS (No	te 6)						
Turn-On Delay Time	t _{d(ON)}				6.9		ns
Rise Time	t _r	V_{GS} = -4.5 V, V_{DS} = -15 V, I_{D} = -2.0 A, R_{G} = 2.0 Ω			11		1
Turn-Off Delay Time	t _{d(OFF)}				60		1
Fall Time	t _f				55		1
DRAIN-SOURCE DIODE CHARACTE	RISTICS						•
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 \text{ V, } I_{S} = -1.5 \text{ A}$ $T_{J} = 25^{\circ}\text{C}$ $T_{J} = 85^{\circ}\text{C}$	T _J = 25°C		-0.75	-1.2	
-					-0.65		V
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V}, d_{IS}/d_t = 100 \text{ A/}\mu\text{s},$ $I_S = -1.5 \text{ A}$			35	60	
Charge Time	ta				10		ns
Discharge Time	t _b				25		1
Reverse Recovery Charge	Q _{RR}				0.016		μС

- 5. Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 6. Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)

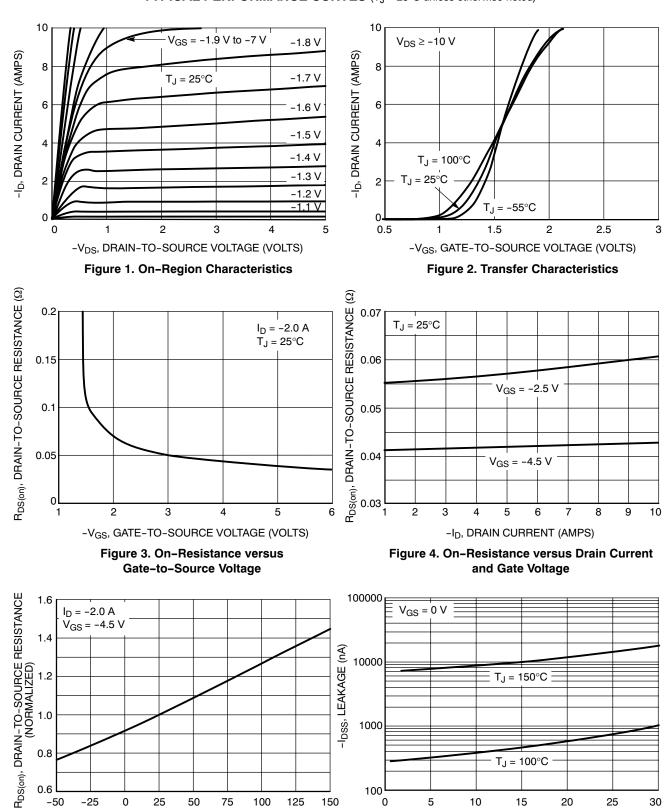


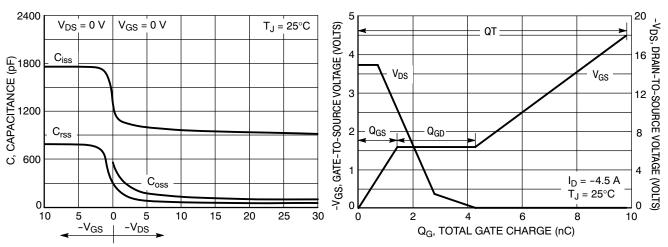
Figure 5. On-Resistance Variation with Temperature

T_J, JUNCTION TEMPERATURE (°C)

Figure 6. Drain-to-Source Leakage Current versus Voltage

-V_{DS}, DRAIN-TO-SOURCE VOLTAGE (VOLTS)

TYPICAL PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

Figure 8. Gate-To-Source and Drain-To-Source Voltage versus Total Charge

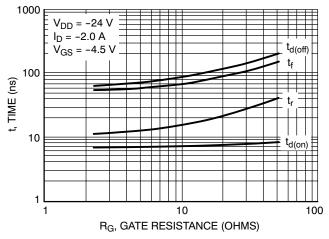


Figure 9. Resistive Switching Time Variation versus Gate Resistance

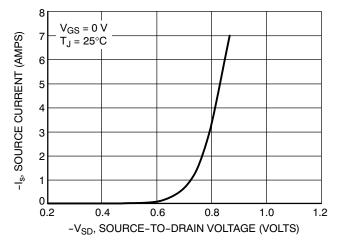
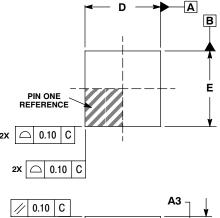
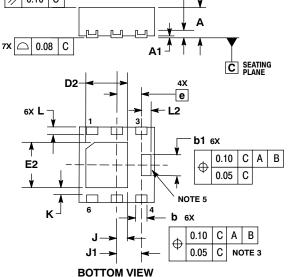


Figure 10. Diode Forward Voltage versus Current

PACKAGE DIMENSIONS

WDFN6 2x2 CASE 506AP-01 ISSUE B



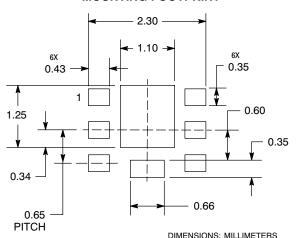


NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS.
 B. DIMENSION & APPLIES TO PLATED TERMINAL AND
- DIMENSION 6 APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.20mm FROM TERMINAL.
- COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.
- 5. CENTER TERMINAL LEAD IS OPTIONAL. TERMINAL LEAD IS CONNECTED TO TERMINAL LEAD # 4.
- PINS 1, 2, 5 AND 6 ARE TIED TO THE FLAG.

	MILLIMETERS		
DIM	MIN	MAX	
Α	0.70	0.80	
A1	0.00	0.05	
A3	0.20 REF		
b	0.25	0.35	
b1	0.51	0.61	
D	2.00 BSC		
D2	1.00	1.20	
E	2.00 BSC		
E2	1.10	1.30	
е	0.65 BSC		
K	0.15 REF		
L	0.20	0.30	
L2	0.20	0.30	
J	0.27 REF		
J1	0.65 REF		

SOLDERMASK DEFINED MOUNTING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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